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REPETITIVE AVALANCHE AND dv/dt RATED HEXFET®TRANSISTORS THRU-HOLE (TO-204AA/AE)

IRF9240 200V, P-CHANNEL

Product Summary

Part Number	BVDSS	RDS(on)	I D
IRF9240	-200V	0.5Ω	-11A

The HEXFET transistors also feature all of the well established advantages of MOSFETs such as voltage control, very fast switching, ease of parelleling and temperature stability of the electrical parameters.

They are well suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high energy pulse circuits.

Features:

- Repetitive Avalanche Ratings
- Dynamic dv/dt Rating
- Hermetically Sealed
- Simple Drive Requirements
- Ease of Paralleling

Absolute Maximum Ratings

	Parameter		Units
$I_D @ V_{GS} = 0V, T_C = 25^{\circ}C$ Continuous Drain Current		-11	
D @ V _{GS} = 0V, T _C = 100°C Continuous Drain Current		-7.0	A
I_{DM}	Pulsed Drain Current ①	-44	1
P_{D} @ $T_{C} = 25^{\circ}C$	Max. Power Dissipation	125	W
	Linear Derating Factor	1.0	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	500	mJ
I_{AR}	Avalanche Current ①	-11	A
EAR	Repetitive Avalanche Energy ①	12.5	mJ
dv/dt	Peak Diode Recovery dv/dt 3	-5.0	V/ns
ТЈ	Operating Junction	-55 to 150	
TSTG	Storage Temperature Range		°C
	Lead Temperature	300 (0.063 in. (1.6mm) from case for 10s)	
	Weight	11.5(typical)	g

NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

Quality Semi-Conductors

IRF9240

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min	Тур	Max	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	-200	_	_	V	$V_{GS} = 0V, I_D = -1.0 \text{mA}$
$\Delta BV_{DSS}/\Delta T_J$	Temperature Coefficient of Breakdown Voltage	_	-0.20	_	V/°C	Reference to 25°C, $I_D = -1.0$ mA
RDS(on)	Static Drain-to-Source On-State	_	_	0.5	Ω	$V_{GS} = -10V, I_D = -7.0A$
,	Resistance	_	_	0.58		$V_{GS} = -10V, I_D = -11A \oplus$
V _{GS} (th)	Gate Threshold Voltage	-2.0	_	-4.0	V	$V_{DS} = V_{GS}$, $I_{D} = -250 \mu A$
gfs	Forward Transconductance	4.0	_	_	S (7)	$V_{DS} > -15V$, $I_{DS} = -7.0A$ ④
IDSS	Zero Gate Voltage Drain Current	_	- -	-25		V _{DS} =-160V, V _{GS} =0V
		_	_	-250	μA	V _{DS} =-160V
						$V_{GS} = 0V, T_J = 125^{\circ}C$
IGSS	Gate-to-Source Leakage Forward	_	_	-100		$V_{GS} = -20V$
IGSS	Gate-to-Source Leakage Reverse	_	-	100	nA	$V_{GS} = 20V$
Qg	Total Gate Charge	28	_	60		$V_{GS} = -10V$, $ID = -11A$
Qgs	Gate-to-Source Charge	3.0	_	15	nC	$V_{DS} = -100V$
Qgd	Gate-to-Drain ('Miller') Charge	4.5	_	38	1	
td(on)	Turn-On Delay Time	_	_	35		$V_{DD} = -100V$, $I_D = -11A$,
tr	Rise Time	_	_	8.5	1	$R_G = 9.1\Omega$
td(off)	Turn-Off Delay Time	_	_	8.5	ns	
tf	Fall Time	_	_	65		
LS + LD	Total Inductance	_	6.1	_	nН	Measured from drain lead (6mm/0.25in. from package) to source lead (6mm/0.25in. from package)
C _{iss}	Input Capacitance	_	1200			$V_{GS} = 0V, V_{DS} = -25V$
Coss	Output Capacitance	-	570	_	pF	f = 1.0MHz
C _{rss}	Reverse Transfer Capacitance	_	81	_		

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
Is	Continuous Source Current (Body Diode)		_	1—1	-11	Α	
ISM	Pulse Source Current (Body Diode) ①		_	_	-44		
VSD	Diode Forward Voltage		_	_	-4.6	V	$T_j = 25$ °C, $I_S = -11$ A, $V_{GS} = 0$ V ④
trr	Reverse Recovery Time		_	270	440	nS	$T_j = 25$ °C, $I_F = -11A$, $di/dt \le -100A/\mu s$
QRR	Reverse Recovery Charge		_	_	7.2	μС	$V_{DD} \le -50V \ \oplus$
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $L_{\mbox{\scriptsize S}}$ + $L_{\mbox{\scriptsize D}}$.					

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
R _{th} JC	Junction-to-Case	_	-	1.0	°C/W	
RthJA	Junction-to-Ambient		_	30	C/W	soldered to a 2" square copper-clad board